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			IBM_TDB			
L2	3	"Siemens Electronics Assembly Systems"	USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/12 15:36
13	1	"Electronics Assembly engineering system"	USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/12 15:42
L4		"Electronics Assembly engineering"	USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/12 15:42

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L1	30462	electronic near4 assembly	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/12 12:21
L2	25	disabl\$3 near8 function near3 edit\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/12 12:32
L3	20	2 and (manufacturing or electronic or assembly)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/12 12:22
L4	14693	disabl\$3 near8 function	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/12 12:32
L5	4	1 same 4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/12 12:32

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John Colter, Netscape Navigator

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